

MNLM2990-12-X REV 0B0

Original Creation Date: 04/30/96

Last Update Date: 09/17/99

Last Major Revision Date: 04/30/96

NEGATIVE LOW DROPOUT REGULATOR

General Description

The LM2990 is low dropout, 1 ampere negative voltage regulator available with fixed output voltages of -5, -12, and -15V.

The LM2990 uses new circuit design techniques to provide low dropout and low quiescent current. The dropout voltage at 1A load current is typically 0.6V and a guaranteed worst-case maximum of 1V over the entire operating temperature range. The quiescent current is typically 1mA with 1A load current and an input-output voltage differential greater than 3V. A unique circuit design of the internal bias supply limits the quiescent current to only 9mA (typical) when the regulator is in the dropout mode ($V_{out} - V_{in} \leq 3V$). Output voltage accuracy is guaranteed to $\pm 5\%$ over load, and temperature extremes.

The LM2990 is short-circuit proof, and thermal shutdown includes hysteresis to enhance the reliability of the device when overloaded for an extended period of time.

Industry Part Number

LM2990

NS Part Numbers

LM2990J-12-QML
LM2990WG-12-QML

Prime Die

LM2990

Controlling Document

SEE FEATURES SECTION

Processing

MIL-STD-883, Method 5004

Quality Conformance Inspection

MIL-STD-883, Method 5005

| Subgrp | Description | Temp (°C) |
|--------|---------------------|------------|
| 1 | Static tests at | +25 |
| 2 | Static tests at | +125 |
| 3 | Static tests at | -55 |
| 4 | Dynamic tests at | +25 |
| 5 | Dynamic tests at | +125 |
| 6 | Dynamic tests at | -55 |
| 7 | Functional tests at | +25 |
| 8A | Functional tests at | +125 |
| 8B | Functional tests at | -55 |
| 9 | Switching tests at | +25 |
| 10 | Switching tests at | +125 |
| 11 | Switching tests at | -55 |

Features

- 5% output accuracy over entire operating range
- Output current in excess of 1A
- Dropout voltage typically 0.6V at 1A load
- Low quiescent current
- Internal short circuit current limit
- Internal thermal shutdown with hysteresis
- Functional complement to the LM2940 series
- CONTROLLING DOCUMENT:

| | |
|-----------------|-----------------|
| LM2990J-12-QML | 5962-9571001QEA |
| LM2990WG-12-QML | 5962-9571001QXA |

Applications

- Post switcher regulator
- Local, on-card, regulation
- Battery operated equipment

(Absolute Maximum Ratings)

(Note 1)

| | |
|---|---------------------------------------|
| Input Voltage | -26V to +0.3V |
| Power Dissipation (Note 2, 3) | Internally Limited |
| Operating Temperature Range (Tj) | -55 C to +125 C |
| Maximum Junction Temperature (Tjmax) | 150 C |
| Storage Temperature Range | -65 C to +150 C |
| Thermal Resistance | |
| ThetaJA | |
| CERDIP | (Still Air @ 0.5 C/W) 75 C/W |
| | (500LF/Min Air flow @ 0.5 C/W) 35 C/W |
| CERAMIC SOIC | (Still Air @ 0.5 C/W) 119 C/W |
| | (500LF/Min Air flow @ 0.5 C/W) TBD |
| ThetaJC | |
| (Note 3) | |
| CERDIP | 5 C/W |
| CERAMIC SOIC | 3 C/W |
| Lead Temperature (Soldering, 10 seconds) | 260 C |
| Package Weight (Typical) | |
| CERDIP | TBD |
| CERAMIC SOIC | TBD |
| ESD Susceptibility (Note 4) | 2kV |

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Note 2: The maximum power dissipation must be derated at elevated temperatures and is dictated by Tjmax (maximum junction temperature), ThetaJA (package junction to ambient thermal resistance), and TA (ambient temperature). The maximum allowable power dissipation at any temperature is $P_{dmax} = (T_{jmax} - T_A) / \Theta_{JA}$ or the number given in the Absolute Maximum Ratings, whichever is lower. If this dissipation is exceeded, the die temperature will rise above 125 C, and the LM2990 will eventually go into thermal shutdown at a Tj of approximately 160 C.

Note 3: The package material for these devices allows much improved heat transfer over our standard ceramic packages. In order to take full advantage of this improved heat transfer, heat sinking must be provided between the package base (directly beneath the die), and either metal traces on, or thermal vias through, the printed circuit board. Without this additional heat sinking, device power dissipation must be calculated using junction-to-ambient, rather than junction-to-case, thermal resistance. It must not be assumed that the device leads will provide substantial heat transfer out of the package, since the thermal resistance of the leadframe material is very poor, relative to the material of the package base. The stated junction-to-case thermal resistance is for the package material only, and does not account for the additional thermal resistance between the package base and the printed circuit board. The user must determine the value of the additional thermal resistance and must combine this with the stated value for the package, to calculate the total allowed power dissipation for the device.

Note 4: Human body model, 100pF discharged through a 1.5K Ohms resistor.

Recommended Operating Conditions

(Note 1)

Maximum Input Voltage (Operational)

-26V

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Electrical Characteristics

DC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)
 DC: $V_{in} = -5V + V_{o(NOM)}$, $I_o = 1A$, $C_o = 47\mu F$.

| SYMBOL | PARAMETER | CONDITIONS | NOTES | PIN-NAME | MIN | MAX | UNIT | SUB-GROUPS |
|-----------|------------------------|---|-------|----------|--------|--------|---------|------------|
| V_o | Output Voltage | $5mA \leq I_o \leq 1A$ | 1 | | -12.24 | -11.76 | V | 1 |
| | | | 1 | | -12.60 | -11.40 | V | 2, 3 |
| V_{rln} | Line Regulation | $I_o = 5mA$, $V_o(NOM) - 1V > V_{in} > -26V$ | 1 | | | 60 | mV | 1, 2, 3 |
| V_{rld} | Load Regulation | $50mA \leq I_o \leq 1A$ | 1 | | | 70 | mV | 1 |
| | | | 1 | | | 100 | mV | 2, 3 |
| V_{do} | Dropout Voltage | $I_o = 0.1A$, $\Delta V_o \leq 100mV$ | 1 | | | 0.3 | V | 1, 2, 3 |
| | | $I_o = 1A$, $\Delta V_o \leq 100mV$ | 1 | | | 1 | V | 1, 2, 3 |
| I_q | Quiescent Current | $I_o \leq 1A$ | 1 | | | 5 | mA | 1 |
| | | | 1 | | | 10 | mA | 2, 3 |
| | | $I_o = 1A$, $V_{in} = V_o(NOM)$ | 1 | | | 50 | mA | 1, 2, 3 |
| I_{os} | Short Circuit Current | $R_l = 1 \text{ Ohm}$ | 1, 2 | | 0.9 | | A | 1 |
| | | | 1, 2 | | 0.75 | | A | 2, 3 |
| I_{max} | Maximum Output Current | | 1, 2 | | 1.4 | | A | 1 |
| R_r | Ripple Rejection | $V_{ripple} = 1V_{rms}$, $F_{ripple} = 1KHz$, $I_o = 5mA$ | 1 | | 42 | | dB | 1 |
| V_{on} | Output Noise Voltage | 10Hz-100KHz, $I_o = 5mA$ | 1 | | | 1500 | μV | 1, 2, 3 |

Note 1: $V_o(NOM)$ is the nominal (typical) regulator output voltage, -5V, -12V or -15V.

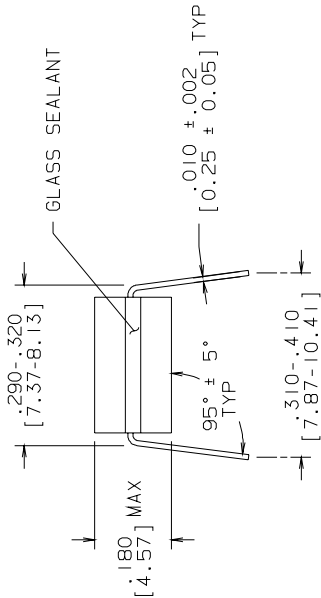
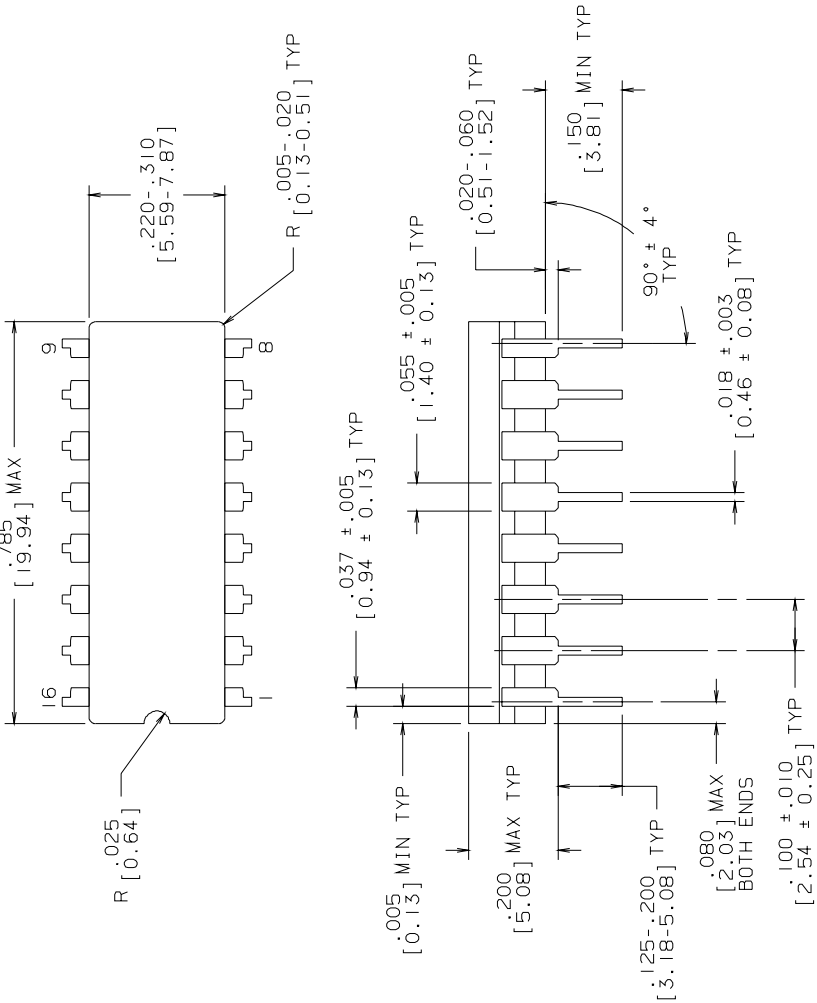
Note 2: The short circuit current is less than the maximum output current with the -12V and -15V versions due to internal foldback current limiting. The -5V version, tested with a lower input voltage, does not reach the foldback current limit and therefore conducts a higher short circuit current level. If the LM2990 output is pulled above ground, the maximum allowed current sunk back into the LM2990 is 1.5A.

Graphics and Diagrams


| GRAPHICS# | DESCRIPTION |
|-----------|--------------------------------------|
| 06324HRB3 | CERDIP (J), 16 LEAD (B/I CKT) |
| 06350HRA1 | CERAMIC SOIC (WG), 16 LEAD (B/I CKT) |
| J16ARL | CERDIP (J), 16 LEAD (P/P DWG) |
| P000100B | CERDIP (J), 16 LEAD (PIN OUT) |
| P000383A | CERAMIC SOIC (WG), 16 LEAD (PINOUT) |
| WG16ARC | CERAMIC SOIC (WG), 16 LEAD (P/P DWG) |

See attached graphics following this page.

| R E V I S I O N S | | | | |
|-------------------|--------------------------------|--------|----------|----------|
| LTR | DESCRIPTION | E.C.N. | DATE | BY/APP'D |
| L | REVISE PER CURRENT STD; REDRAW | 09996 | 09/15/93 | TL/ |

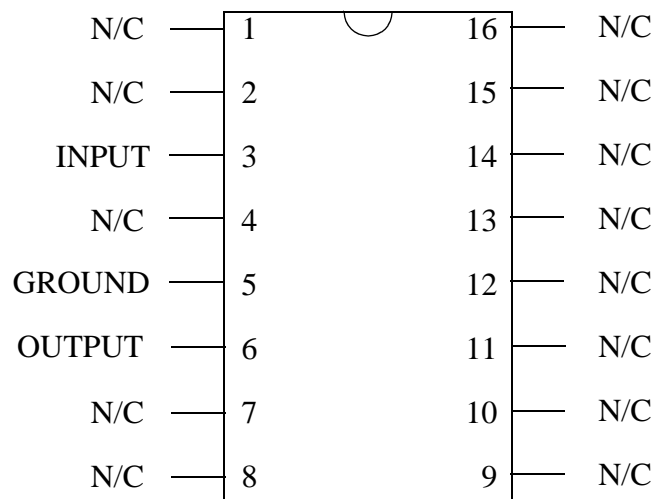


MIL/AERO MIL-M-38510
 CONFIGURATION CONTROL CONFIGURATION CONTROL

| CONTROLLING DIMENSION: INCH | | | | |
|---|----------|--|-----------|----------------------------|
| APPROVALS | DATE | NATIONAL SEMICONDUCTOR CORPORATION | | |
| DRAWN LEQUANG | 09/15/93 | 2900 Semiconductor Drive, Santa Clara, CA 95052-8090 | | |
| DFTG. CHK. | | | | |
| ENGR. CHK. | | | | |
| APPROVAL | | | | |
| PROJECTION  | | SCALE N/A | SIZE B | DRAWING NUMBER MKT-J16A |
| | | DO NOT SCALE | DRAWING | SHEET 1 OF 1 |

- NOTES: UNLESS OTHERWISE SPECIFIED
1. LEAD FINISH TO BE 200 MICRONS / 5.08 MICROMETERS MINIMUM SOLDER MEASURED AT THE CREST OF THE MAJOR FLATS.
 2. JEDEC REGISTRATION M0-036, VARIATION AD, DATED 04/1981.

CERDIP (J) ,
 16 LEAD



LM2990J-XX

16 - LEAD DIP

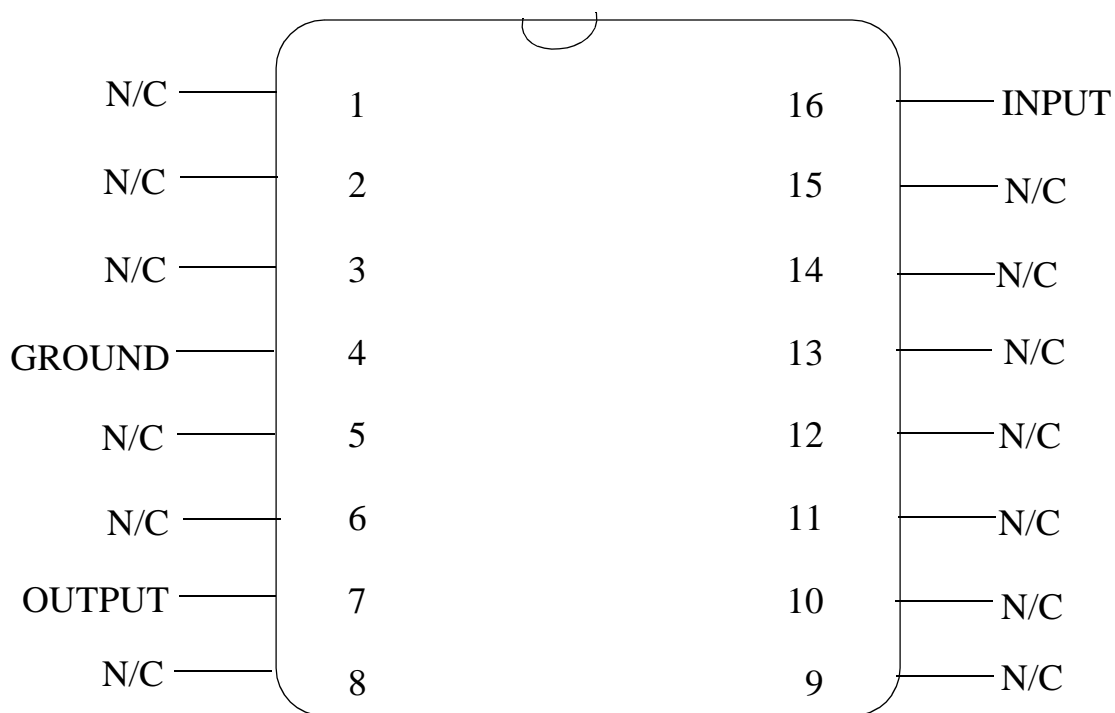
CONNECTION DIAGRAM

(TOP VIEW)

P000100B



National Semiconductor™
MIL/AEROSPACE OPERATIONS
2900 SEMICONDUCTOR DRIVE
SANTA CLARA, CA 95050

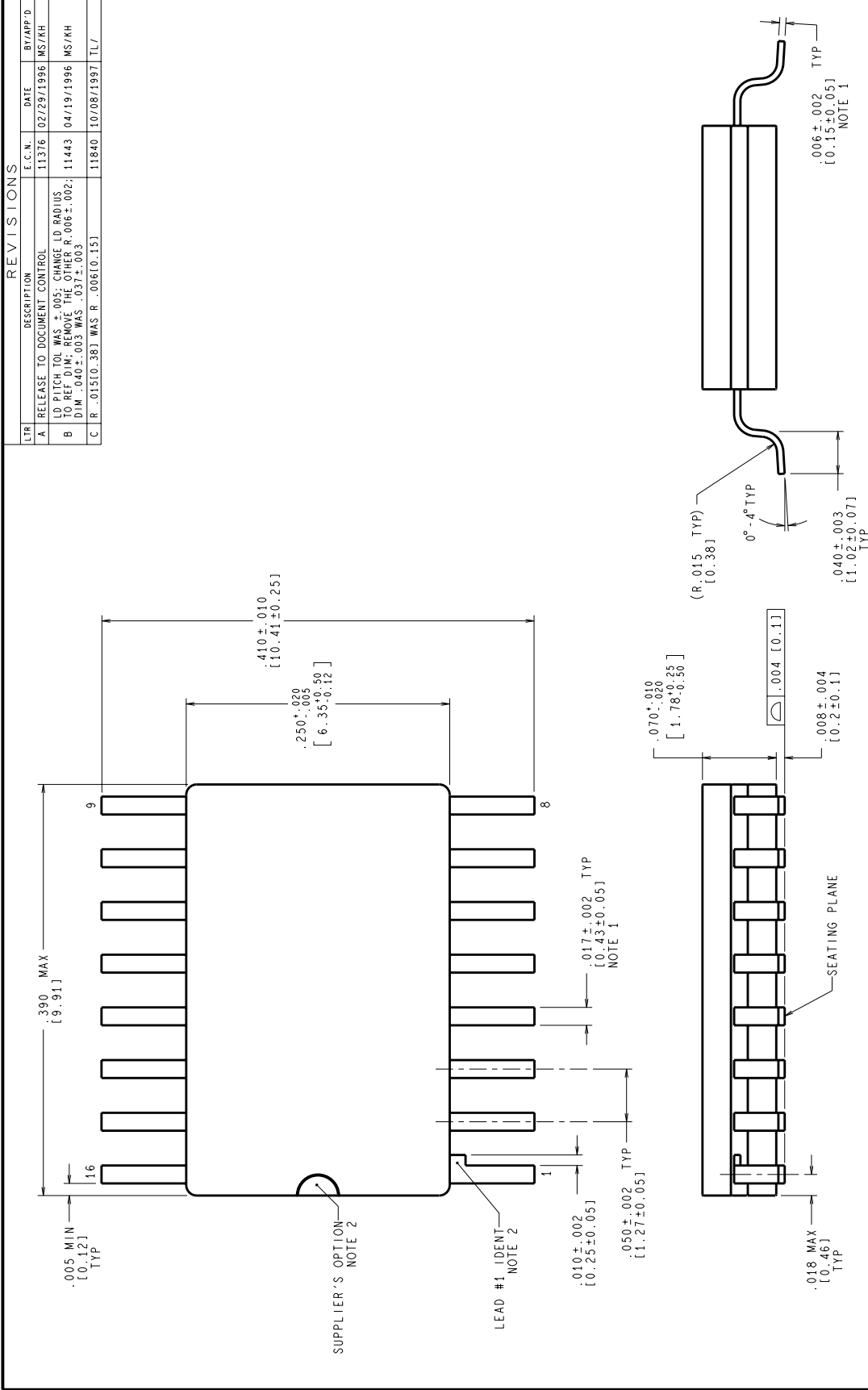


LM2990WG
16 - LEAD CERAMIC SOIC
CONNECTION DIAGRAM
TOP VIEW
P000383A



National Semiconductor™
MIL/AEROSPACE OPERATIONS
2900 SEMICONDUCTOR DRIVE
SANTA CLARA, CA 95050

| REVISIONS | | | |
|-----------|---|--------|------------|
| LTR | DESCRIPTION | E.C.N. | DATE |
| A | RELEASE TO DOCUMENT CONTROL | 11376 | 02/29/1996 |
| B | LD PITCH TOL WAS $\pm .005$; CHANGE LD RADIUS TO REF DIM; REMOVE THE OTHER R .006 $\pm .002$; DIM .040 $\pm .003$ WAS $.037 \pm .003$ | 11443 | 04/19/1996 |
| C | R .015(0.38) WAS R .006(0.15) | 11840 | 10/08/1997 |



NOTES: UNLESS OTHERWISE SPECIFIED

- LEAD FINISH: SOLDER DIPPED WITH Sn60 OR Sn63 SOLDER CONFORMING TO MIL-PRF-38535 TO A MINIMUM THICKNESS OF 200 MICRONS/ 5.08 MICROMETERS. SOLDER MAY BE APPLIED OVER LEAD BASE METAL OR Sn PLATE. MAXIMUM LIMIT MAY BE INCREASED BY .003 IN/ 0.08mm AFTER LEAD FINISH APPLIED.
- LEAD 1 IDENTIFICATION SHALL BE:
 - A NOTCH OR OTHER MARK WITHIN THIS AREA
 - A TAB ON LEAD 1, EITHER SIDE
- NO JEDEC REGISTRATION AS OF FEBRUARY 1996.

MIL-PRF-38535 CONFIGURATION CONTROL

| APPROVALS | DATE | SCALE | SIZE | DRAWING NUMBER | REV |
|--|----------|-------|------|----------------|-----|
| DESIGN MARTY SUCHY | 02/29/96 | N/A | C | (SC)MKT-WG16A | C |
| ENGINEER CHK. | | | | | |
| TESTER CHK. | | | | | |
| <div> </div> | | | | | |
| <div> </div> | | | | | |
| <div> <p>CERPACK, 16 LEAD, GULL WING</p> </div> | | | | | |
| <div> <p>2000 Semiconductor Dr., Santa Clara, CA 95052-8000</p> </div> | | | | | |
| DO NOT SCALE DRAWING | | | | | |
| SHEET 1 of 1 | | | | | |

Revision History

| Rev | ECN # | Rel Date | Originator | Changes |
|-----|----------|----------|---------------|---|
| 0A0 | M0000593 | 09/17/99 | Barbara Lopez | Initial Release of: MNLM2990-12-X Rev. 0A0. Added note for power dissipation and reference to thermal resistance for Aluminum Nitride package. |
| 0B0 | M0003561 | 09/17/99 | Rose Malone | Update MDS: MNLM2990-12-X, Rev. 0A0 to MNLM2990-12-X, Rev. 0B0. Moved reference to Controlling Document to Features Section. Added graphic's reference to WG Pkg to Main Table and Absolute Section and Package Weight heading. |